National Semiconductor

MICROCIRCUIT DATA SHEET

MNLM2941-X REV 4A1

Original Creation Date: 03/21/97
Last Update Date: 05/04/01
Last Major Revision Date: 04/20/01

LOW DROPOUT ADJUSTABLE REGULATOR

General Description

The LM2941 positive voltage regulator features the ability to source 1A of output current with a typical dropout voltage of 0.5V and a maximum of 1V over the entire temperature range. Furthermore, a quiescent current reduction circuit has been included which reduces the ground pin current when the differential between the input voltage and the output voltage exceeds approximately 3V. The quiescent current with 1A of output current and an input-output differential of 5V is therefore only 30mA. Higher quiescent currents only exist when the regulator is in the dropout mode (Vin - Vout $\leq$ 3V).

Designed also for vehicular applications, the LM2941 and all regulated circuitry are protected from reverse battery installations or two-battery jumps. During line transients, such as load dump when the input voltage can momentarily exceed the specified maximum operating voltage, the regulator will automatically shut down to protect both the internal circuits and the load. Familiar regulator features such as short circuit and thermal overload protection are also provided.

Industry Part Number

LM2941

Prime Die

LM2941

Controlling Document

SEE FEATURES SECTION

NS Part Numbers

LM2941J-MLS
LM2941J-QMLV
LM2941J/883
LM2941WG-QMLV
LM2941WG/883

Processing

MIL-STD-883, Method 5004

Quality Conformance Inspection

MIL-STD-883, Method 5005

Subgrp	Description	Temp (^{O}C)
1	Static tests at	+25
2	Static tests at	+125
3	Static tests at	-55
4	Dynamic tests at	+25
5	Dynamic tests at	+125
6	Dynamic tests at	-55
7	Functional tests at	+25
8A	Functional tests at	+125
8B	Functional tests at	-55
9	Switching tests at	+25
10	Switching tests at	+125
11	Switching tests at	-55

Features

- Output voltage adjustable from 5V to 20V
- Dropout voltage typically 0.5V @ Io = 1A
- Output current in excess of 1A
- Trimmed reference voltage
- Reverse battery protection
- Internal short circuit current limit
- Mirror image insertion protection
- TTL, CMOS compatible ON/OFF switch
- CONTROLLING DOCUMENT

LM2941J-QMLV	5962-9166701VEA
LM2941J/883	5962-9166701QEA
LM2941WG-QMLV	5962-9166701VYA
LM2941WG/883	5962-9166701QYA

(Absolute Maximum Ratings)

(Note 1)

Input Voltage (Survival Voltage ≤ 100mS)		60V
Internal Power Dissipation (Note 2, 3)		Internally Limited
Maximum Junction Temperature		150 C
Storage Temperature Range		-65 C ≤ TA ≤ +150 C
Lead Temperature (Soldering, 10 seconds)		300 C
Thermal Resistance		
ThetaJA		
CERDIP	(Still Air)	73 C/W
CERDIP	(500LF/Min Air Flow)	37 C/W
CERAMIC SOIC	(Still Air)	122 C/W
CERAMIC SOIC	(500LF/Min Air Flow)	77 C/W
ThetaJC		
CERDIP		3 C/W
CERAMIC SOIC		5 C/W
Package Weight (Typcial)		
CERDIP		1970mg
CERAMIC SOIC		360mg
ESD Susceptibility (Note 4)		500V

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Note 2: The maximum power dissipation must be derated at elevated temperatures and is dictated by Tjmax (maximum junction temperature), ThetaJA (package junction to ambient thermal resistance), and TA (ambient temperature). The maximum allowable power dissipation at any temperature is Pdmax = (Tjmax - TA)/ThetaJA or the number given in the Absolute Maximum Ratings, whichever is lower.

Note 3: The package material for these devices allows much improved heat transfer over our standard ceramic packages. In order to take full advantage of this improved heat transfer, heat sinking must be provided between the package base (directly beneath the die), and either metal traces on, or thermal vias through, the printed circuit board. Without this additional heat sinking, device power dissipation must be calculated using junction-to-ambient, rather than junction-to-case, thermal resistance. It must not be assumed that the device leads will provide substantial heat transfer out of the package, since the thermal resistance of the leadframe material is very poor, relative to the material of the package base. The stated junction-to-case thermal resistance is for the package material only, and does not account for the additional thermal resistance between the package base and the printed circuit board. The user must determine the value of the additional thermal resistance and must combine this with the stated value for the package, to calculate the total allowed power dissipation for the device.

Note 4: Human body model, 100pF discharged through 1.5K Ohms.

Recommended Operating Conditions

(Note 1)

Input Voltage	26V
Operating Temperature Range	-55 C ≤ TA ≤ +125 C

Note 1: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. For guaranteed specifications and test conditions, see the Electrical Characteristics. The guaranteed specifications apply only for the test conditions listed. Some performance characteristics may degrade when the device is not operated under the listed test conditions.

Electrical Characteristics

DC PARAMETERS:

(The following conditions apply to all the following parameters, unless otherwise specified.)
DC: 5V ≤ Vo ≤ = 20V, Vin = Vo +5V, Cout = 22uF

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
Vref	Reference Voltage	5mA ≤ Io ≤ 1A			1.237	1.313	V	1
					1.211	1.339	V	2, 3
Vrline	Line Regulation	Vo + 2V ≤ Vin ≤ 26V, Io = 5mA	3			10	mV/V	1, 2, 3
Vrload	Load Regulation	50mA ≤ Io ≤ 1A	3			10	mV/V	1, 2, 3
Iq	Quiescent Current	Vo + 2V ≤ Vin ≤ 26V, Io = 5mA				15	mA	1
						20	mA	2, 3
		Vin = Vo + 5V, Io = 1A				45	mA	1
						60	mA	2, 3
Vdo	Dropout Voltage	Io = 1A				0.8	V	1
						1.00	V	2, 3
		Io = 100mA				200	mV	1
						300	mV	2, 3
Isc	Short Circuit Current	Vin max = 26V			1.6	3.5	A	1
					1.3	3.7	A	2, 3
	Maximum Operational Input Voltage		2			26	Vdc	1, 2, 3
	Reverse Polarity DC Input Voltage	Ro = 100 Ohms, Vo ≥ -0.6V	1		-15		V	1, 2, 3
V(TO)	ON/OFF Threshold Voltage ON	Io ≤ 1A	1			0.8	V	1, 2, 3
V(TO)	ON/OFF Threshold Voltage OFF	Io ≤ 1A	1		2.00		V	1, 2, 3
	ON/OFF Threshold Current	V ON/OFF = 2.0V, Io ≤ 1A				100	uA	1
						300	uA	2, 3

Electrical Characteristics

AC PARAMETERS:

(The following conditions apply to all the following parameters, unless otherwise specified.)
AC: 5V ≤ Vo ≤ = 20V, Vin = Vo +5V, Cout = 22uF

SYMBOL	PARAMETER	CONDITIONS	NOTES	PIN-NAME	MIN	MAX	UNIT	SUB-GROUPS
	Maximum Line Transient	Vo max 1V above nominal Vo, Ro = 100 Ohms, T ≤ 100mS			60		V	4, 5, 6
	Reverse Polarity Transient Input Voltage	T ≤ 100mS, Ro = 100 Ohms			-50		V	4, 5, 6
RR	Ripple Rejection	fo = 1KHz, 1 Vrms, IL = 100mA	4			0.02	%/V	4
			4			0.04	%/V	5, 6

DC PARAMETERS: DRIFT VALUES

(The following conditions apply to all the following parameters, unless otherwise specified.)
AC: 5V ≤ Vo ≤ = 20V, Vin = Vo +5V, Cout = 22uF. "Delta Calculations performed on JAN S and QMLV devices at Group B, Subgroup 5 ONLY"

Vref	Reference Voltage	5mA ≤ Io ≤ 1A			-25	+25	mV	1

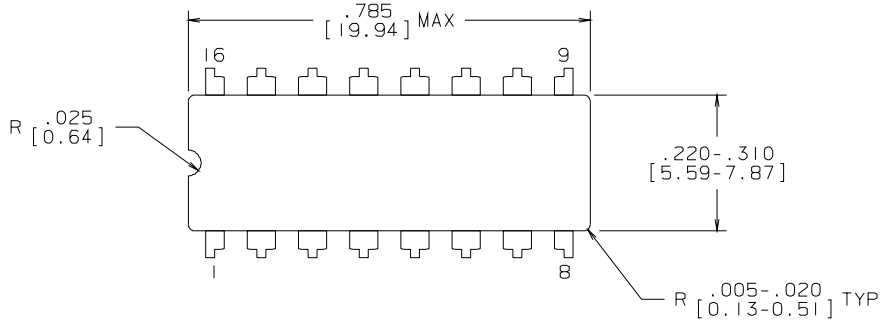
Note 1: Functional test go no go only.
Note 2: Condition for Vin.
Note 3: Limit = mV per Volt of Vout.
Note 4: %/V = % of Vin per Volt of Vout.

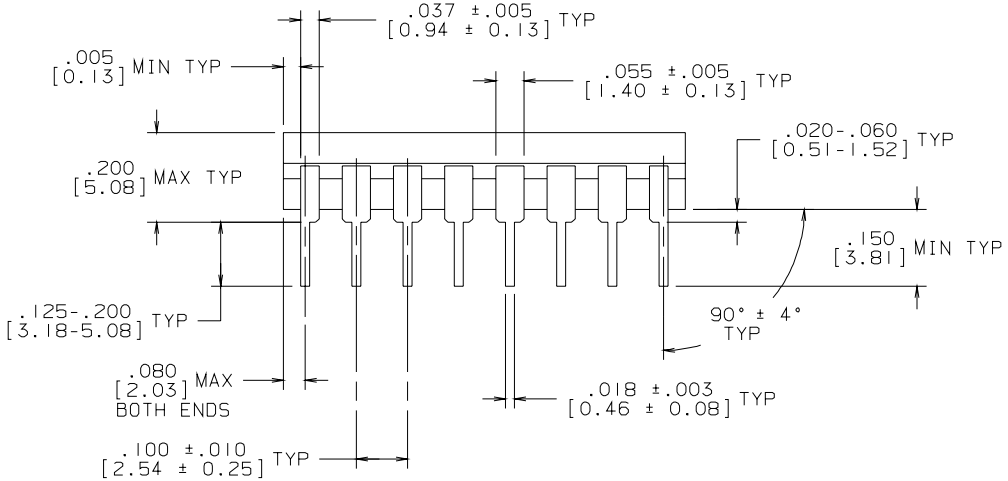
Graphics and Diagrams

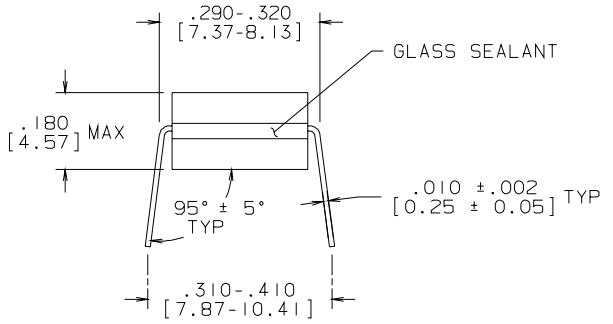
GRAPHICS#	DESCRIPTION
06333HRA2	CERDIP (J), 16 LEAD (B/I CKT)
06352HRA1	CERPACK (W), 16 LEAD (B/I CKT)
J16ARL	CERDIP (J), 16 LEAD (P/P DWG)
P000158A	CERDIP (J), 16 LEAD (PINOUT)
P000378A	CERAMIC SOIC, 16 LEAD (PINOUT)
WG16ARC	CERAMIC SOIC (WG), 16 LEAD (P/P DWG)

See attached graphics following this page.

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
L	REVISE PER CURRENT STD; REDRAW	09996	09/15/93	TL/







MIL/AERO CONFIGURATION CONTROL

MIL-M-38510 CONFIGURATION CONTROL

CONTROLLING DIMENSION: INCH

APPROVALS	DATE
DRAWN T. LEQUANG	09/15/93
DFTG. CHK.	
ENGR. CHK.	
APPROVAL	

NATIONAL SEMICONDUCTOR CORPORATION
2900 Semiconductor Drive, Santa Clara, CA 95052-8090

CERDIP (J), 16 LEAD

PROJECTION

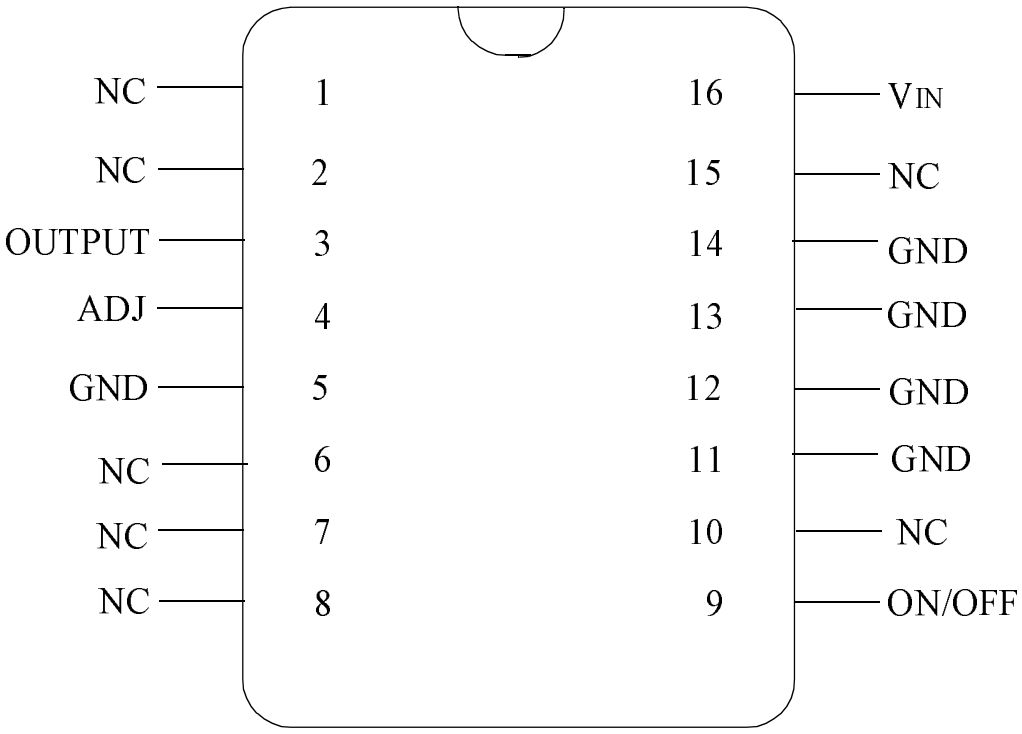
INCH [MM]

SCALE	SIZE	DRAWING NUMBER	REV
N/A	B	MKT-J16A	L

DO NOT SCALE DRAWING | SHEET 1 OF 1

NOTES: UNLESS OTHERWISE SPECIFIED

1. LEAD FINISH TO BE 200 MICROINCHES / 5.08 MICROMETERS MINIMUM SOLDER MEASURED AT THE CREST OF THE MAJOR FLATS.
2. JEDEC REGISTRATION MO-036, VARIATION AD, DATED 04/1981.



LM2941J/883

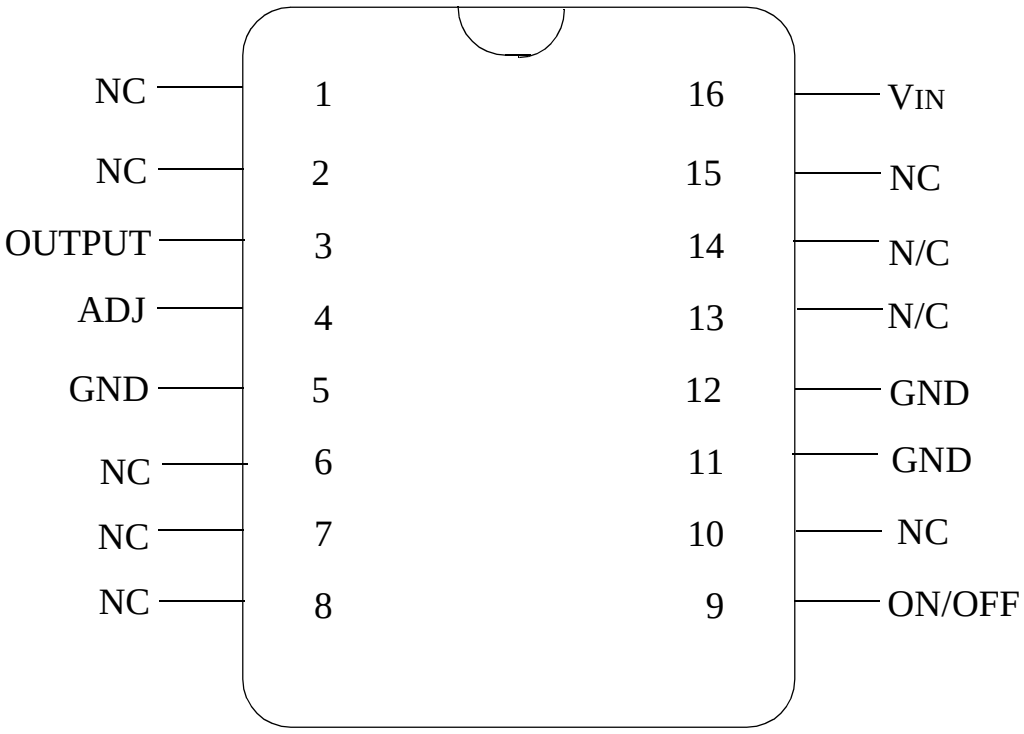
16 - LEAD DIP

CONNECTION DIAGRAM

TOP VIEW

P000158A

National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050



LM2941WG

16 - LEAD CERAMIC SOIC

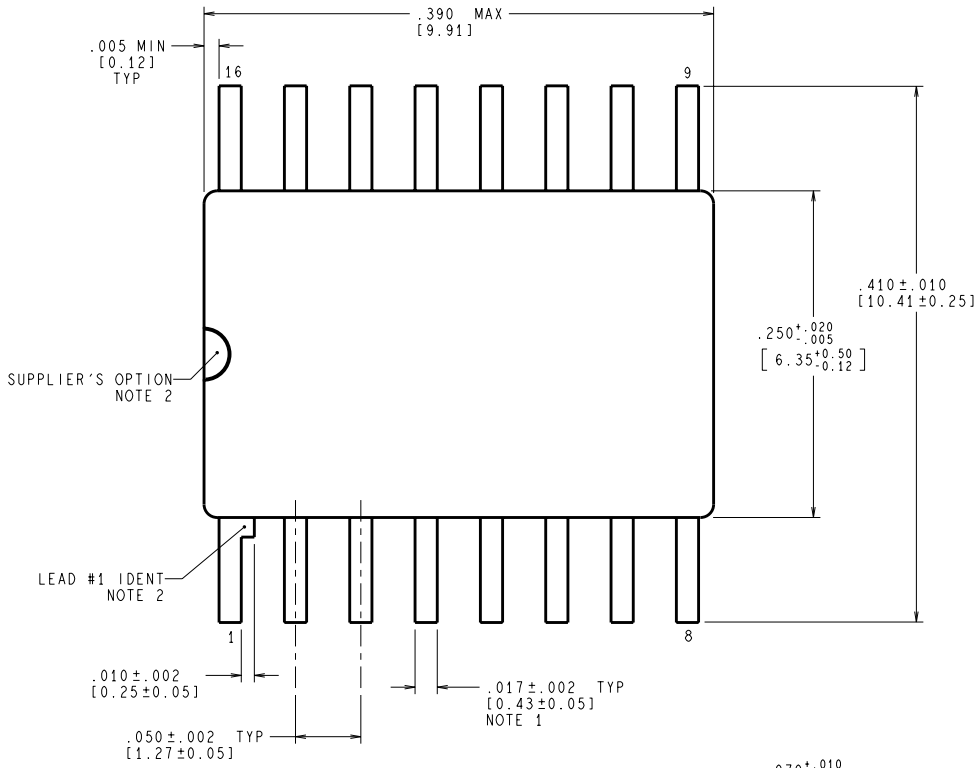
CONNECTION DIAGRAM

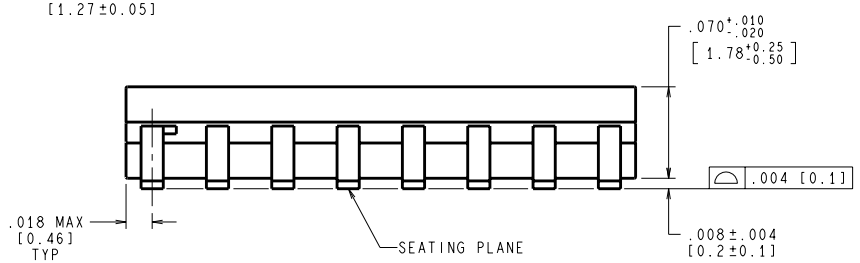
TOP VIEW

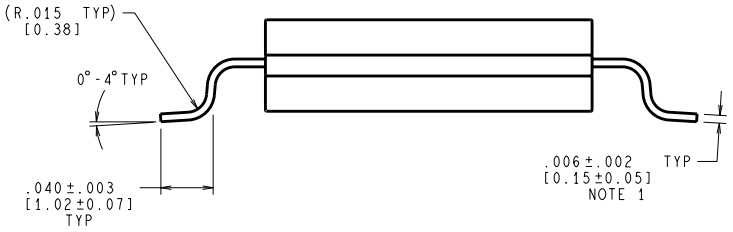
P000378A

National Semiconductor™
MIL/AEROSPACE OPERATIONS
2900 SEMICONDUCTOR DRIVE
SANTA CLARA, CA 95050

REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	11376	02/29/1996	MS/KH
B	LD PITCH TOL WAS ±.005; CHANGE LD RADIUS TO REF DIM; REMOVE THE OTHER R.006±.002; DIM .040±.003 WAS .037±.003	11443	04/19/1996	MS/KH
C	R .015[0.38] WAS R .006[0.15]	11840	10/08/1997	TL/







NOTES: UNLESS OTHERWISE SPECIFIED

1. LEAD FINISH: SOLDER DIPPED WITH Sn60 OR Sn63 SOLDER CONFORMING TO MIL-PRF-38535 TO A MINIMUM THICKNESS OF 200 MICROINCHES/ 5.08 MICROMETERS. SOLDER MAY BE APPLIED OVER LEAD BASIS METAL OR Sn PLATE. MAXIMUM LIMIT MAY BE INCREASED BY .003 IN/ 0.08mm AFTER LEAD FINISH APPLIED.
2. LEAD 1 IDENTIFICATION SHALL BE:
   a) A NOTCH OR OTHER MARK WITHIN THIS AREA
   b) A TAB ON LEAD 1, EITHER SIDE
3. NO JEDEC REGISTRATION AS OF FEBRUARY 1996.

CONTROLLING DIMENSION IS INCH
VALUES IN [ ] ARE MILLIMETERS

MIL-PRF-38535
CONFIGURATION CONTROL

APPROVALS	DATE
DRAWN: MARTA SUCHY	02/29/96
DFTG. CHK.	
ENGR. CHK.	

National Semiconductor
2900 Semiconductor dr, Santa Clara, CA 95052-8090

CERPACK, 16 LEAD, GULL WING

PROJECTION
INCH [MM]

SCALE	SIZE	DRAWING NUMBER	REV
N/A	C	(SC)MKT-WG16A	C

DO NOT SCALE DRAWING | SHEET 1 of 1

Revision History

Rev	ECN #	Rel Date	Originator	Changes
0A0	M0001075	02/11/99	Barbara Lopez	Initial Release of: MNLM2941-X Rev. 0A0. Added note for power dissipation and reference to thermal resistance for Aluminum Nitride package.
1A1	M0003224	10/08/99	Rose Malone	Update MDS: MNLM2941-X, Rev. 0A0 to MNLM2941-X, Rev. 1A1.
2A1	M0003559	11/28/00	Rose Malone	Update MDS: MNLM2941-X, Rev. 1A1 to MNLM2941-X, Rev. 2A1. Changed Vdo, Io = 100mA, Max. condition subgroups to Subgroup 1 at 200mV and Subgroup 2 and 3 at 300mV.
2B1	M0003777	01/31/01	Rose Malone	Update MDS: MNLM2941-X, Rev. 2A1 to MNLM2941-X, Rev. 2B1. Added MLS part number reference to Main Table.
3A1	M0003783	05/04/01	Rose Malone	Update MDS: MNLM2941-X, Rev. 2B1 to MNLM2941-X, Rev. 3A1. Changed Electrical Section DC parameter Isc Max limit Subgroup 1 from 3.3A to 3.5A and Subgroups 2, 3 from 3.5A to 3.7A
4A1	M0003801	05/04/01	Rose Malone	Update MDS: MNLM2941-X, Rev. 3A1 to MNLM2941-X, Rev. 4A1. Removed on Main Table, Feature Section and Graphics Section reference to K pkg. Added Main Table, Feature Section reference to WG pkg and Drift Value Parameter to Electrical Section.